

# **Test Report**

Report No.: CEBDBO-WTW-P21030872

Test Model: MIG-1000

Series Model: MIG-1 XXXXXXXXXXXXXXXXXX

("X" can be 0-9, A-Z or blank for marketing purposes)

Received Date: Mar. 24, 2021

Test Date: Mar. 24 to Apr. 8, 2021

Issued Date: Apr. 14, 2021

Applicant: Vecow Co., Ltd.

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Issued By: Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch Lin Kou Laboratories

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## **Release Control Record**

Issue No.	Description	Date Issued
CEBDBO-WTW-P21030872	Original release.	Apr. 14, 2021

## 1 Certificate of Conformity

Product:	GPU computing System
Brand:	Vecow
Test Model:	MIG-1000
Series Model:	MIG-1 XXXXXXXXXXXXXXX
	("X" can be 0-9, A-Z or blank for marketing purposes)
Sample Status:	Engineering sample
Applicant:	Vecow Co., Ltd.
Test Date:	Mar. 24 to Apr. 8, 2021
Standards:	EN 55032:2015 +A11:2020, Class A
	CISPR 32:2015+Cor1:2016, Class A
	AS/NZS CISPR 32:2015, Class A
	EN 61000-3-2:2014, Class D
	EN 61000-3-3:2013
	EN 55035:2017 +A11:2020
	EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0
	EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2
	EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0
	EN 61000-4-5:2014 +A1:2017 / IEC 61000-4-5:2014 +A1:2017 ED. 3.0
	EN 61000-4-6:2014 +AC:2015 / IEC 61000-4-6:2013 ED. 4.0
	EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0
	EN 61000-4-11:2004 +A1:2017 / IEC 61000-4-11:2004 +A1:2017 ED. 2.0
	Broadband impulse noise disturbances (Not applicable)

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

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Prepared by :	Jessica Chorg Jessica Cheng / Senior Specialist	_ , Date:	Apr. 14, 2021
Approved by :	Jim Hsiang / Associate Technical Manager	_ , Date:	Apr. 14, 2021



# 2 Summary of Test Results

Emission				
Standard Test Item Result/Remarks			Verdict	
	Conducted emission from the AC mains power port	Minimum passing Class A margin is -19.02 dB at 1.53516 MHz	Pass	
EN 55032:2015 +A11:2020 CISPR 32:2015+Cor1:2016	Asymmetric mode conducted emission at telecommunication ports	Minimum passing Class A margin is -27.17 dB at 29.99609 MHz	Pass	
AS/NZS CISPR 32:2015	Radiated emission 30-1000 MHz	Minimum passing Class A margin is -7.51 dB at 192.01 MHz	Pass	
	Radiated emission above 1GHz	Minimum passing Class A margin is -13.09 dB at 1592.00 MHz	Pass	
EN 61000-3-2:2014	Harmonic current emissions	Class D	Pass	
EN 61000-3-3:2013	Voltage fluctuations and flicker	$\begin{array}{ll} P_{st} \leqq 1.0 & d_{max} \leqq 4\% \\ P_{lt} \leqq 0.65 & d_{c} \leqq 3.3\% \\ T_{max} \leqq 500 \text{ms} \end{array}$	Pass	



Immunity					
EN 55035 Clause	Basic standard	Test Item	Result/Remarks	Verdict	
4.2.1	EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0	Electrostatic Discharge (ESD)	Performance Criterion B	Pass	
4.2.2.2	EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2	Continuous radiated disturbances (RS)	Performance Criterion A	Pass	
4.2.4	EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0	Electrical fast transients (EFT)	Performance Criterion A	Pass	
4.2.5	EN 61000-4-5:2014 +A1:2017 / IEC 61000-4-5:2014 +A1:2017 ED. 3.0	Surges	Performance Criterion A	Pass	
4.2.2.3	EN 61000-4-6:2014 +AC:2015 / IEC 61000-4-6:2013 ED. 4.0	Continuous conducted disturbances (CS)	Performance Criterion A	Pass	
4.2.3	EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0	Power-frequency magnetic fields (PFMF)	Performance Criterion A	Pass	
4.2.6	EN 61000-4-11:2004 +A1:2017 / IEC 61000-4-11:2004 +A1:2017 ED. 2.0	Voltage dips and interruptions	Voltage Dips: <5% residual – 0.5 cycle, Performance Criterion A 70% residual – 25 cycles, Performance Criterion C Voltage Interruptions: <5% residual – 250 cycles, Performance Criterion C	Pass	
4.2.7	-	Broadband impulse noise disturbances, <b>Repetitive</b> (Applicable only to xDSL ports.)	Without CPE xDSL port of the EUT.	N/A	
4.2.7	-	Broadband impulse noise disturbances, <b>Isolated</b> (Applicable only to	Without CPE xDSL port of the EUT.	N/A	

Note:

 The above EN/IEC basic standards are applied with latest version if customer has no special requirement.
There is no deviation to the applied test methods and requirements covered by the scope of this report. 3. Determining compliance based on the results of the compliance measurement, not taking into account

measurement instrumentation uncertainty.

4. N/A: Not Applicable



## 2.1 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expanded Uncertainty (k=2) (±)	Maximum allowable uncertainty (±)
Conducted emission from AC mains power port using AMN, 150kHz ~ 30MHz	3.00 dB	3.4 dB ( <i>U</i> <sub>cispr</sub> )
Asymmetric mode conducted emission using AAN, 150kHz ~ 30MHz	3.94 dB	5.0 dB ( <i>U</i> <sub>cispr</sub> )
Radiated emission, 30MHz ~ 1GHz	4.30 dB	6.3 dB ( <i>U</i> <sub>cispr</sub> )
Radiated emission, 1GHz ~ 6GHz	4.96 dB	5.2 dB ( <i>U</i> <sub>cispr</sub> )

## 2.2 Modification Record

There were no modifications required for compliance.



## 3 General Information

## 3.1 Description of EUT

Product	GPU computing System
Brand	Vecow
Test Model	MIG-1000
Series Model	MIG-1 XXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purposes)
Model Difference	Marketing Differentiation
Sample Status	Engineering sample
Operating Software	Windows 10
Power Supply Rating	DC from Adapter
Accessory Device	N/A
Data Cable Supplied	N/A

Note:

## 1. The EUT uses following adapter.

Brand	LITEON		
Model	PA-1181-28		
Input Power	100-240Vac, 2.34A, 50-60Hz		
Output Power	24Vdc, 7.5A, 180.0W		
Power Line	AC 3-Pin Non-shielded DC (1.8m) with two ferrite cores.		

## 3.2 Features of EUT

1. The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.

2. The EUT was configured with the following key components:

Components	Brand	Model	Specification
CPU	AMD RYZEN EMBEDDED	V1807B	3343.9MHz
RAM	innodisk	-	8GB DDR4 2666 SODIMM
SSD	innodisk	-	2.5" SATA SSD 3ME4 256GB



## 3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode

- 1. The EUT was pre-tested under operating and standby condition and the worst emission level was found under **operating condition**.
- 2. The EUT consumed power from AC adapter, which designed with AC power supply of 100-240Vac, 50-60Hz.

For radiated emission evaluation, 230Vac/ 50Hz & 110Vac/ 60Hz had been covered during the pre-test. The worst radiated emission data was found at 230Vac/ 50Hz and recorded in the applied test report.

## 3. Test modes are presented in the report as below.

Mode	Input Power			
	Conducted emission test			
1	Full system (DP * 4: 4096*2160, 60Hz)	230Vac/ 50Hz &		
-		110Vac/ 60Hz		
	Asymmetric mode conducted emission at telecommunication ports te	st		
1A	Full system (DP * 4: 4096*2160, 60Hz) - LAN 1 port: Speed (1Gbps)	230Vac/ 50Hz		
1B	Full system (DP * 4: 4096*2160, 60Hz) - LAN 2 port: Speed (1Gbps)	230740/ 20112		
The idle n	node of conducted emission test at telecom port was pre-tested based on the	worst case of link		
mode. Du	e to emissions of idle mode being very low compared to link mode, only the lir	nk mode data were		
presented	presented in the test report.			
	Radiated emission test			
1	Full system (DP * 4: 4096*2160, 60Hz)	230Vac/ 50Hz		
Harmonics & Flicker and Immunity tests				
1	Full system (DP * 4: 4096*2160, 60Hz)	230Vac/ 50Hz		

## 3.4 Test Program Used and Operation Descriptions

## Emission tests (Harmonics & Flicker excluded):

- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to SSD and ext. HDD.
- d. EUT sent and received messages to/from Notebook PC/ PC (kept in a remote area) via two UTP LAN cables (10m each).
- e. EUT sent "color bars with moving element" messages to ext. LCD Monitors. Then they displayed "color bars with moving element" messages on their screens simultaneously.
- f. EUT sent messages to printer and printer printed them out.
- g. EUT sent 1kHz audio signal to earphone.
- h. Steps c-g were repeated.

### Harmonics, Flicker, Immunity tests:

- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to SSD and ext. USB HDDs.
- d. EUT sent and received messages to/from Notebook PCs (kept in a remote area) via two UTP LAN cables.
- e. EUT sent "color bars with moving element" messages to ext. LCD Monitors. Then they displayed "color bars with moving element" messages on their screens simultaneously.
- f. EUT sent audio signal to speaker.
- g. Steps c-f were repeated.

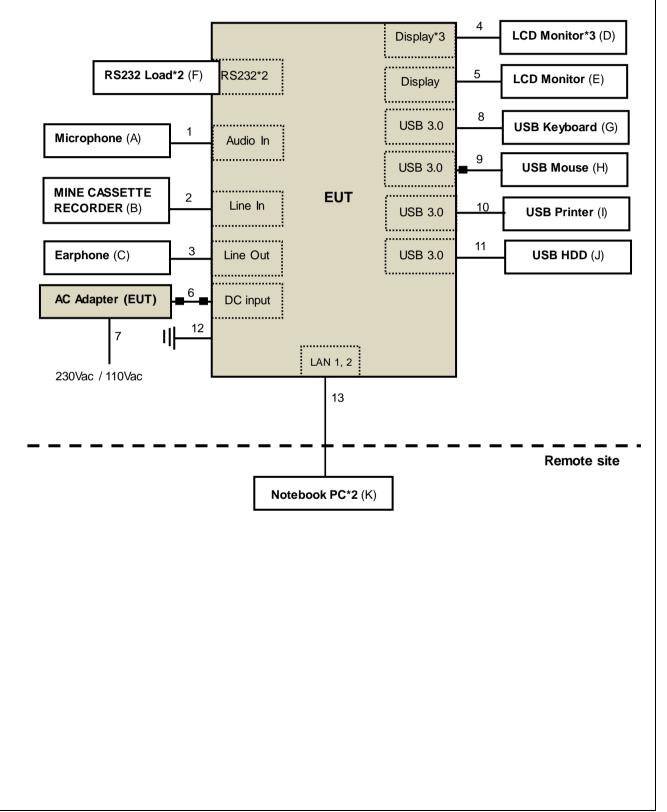
### 3.5 Primary Clock Frequencies of Internal Source

The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 3.3GHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.

## 4 Configuration and Connections with EUT

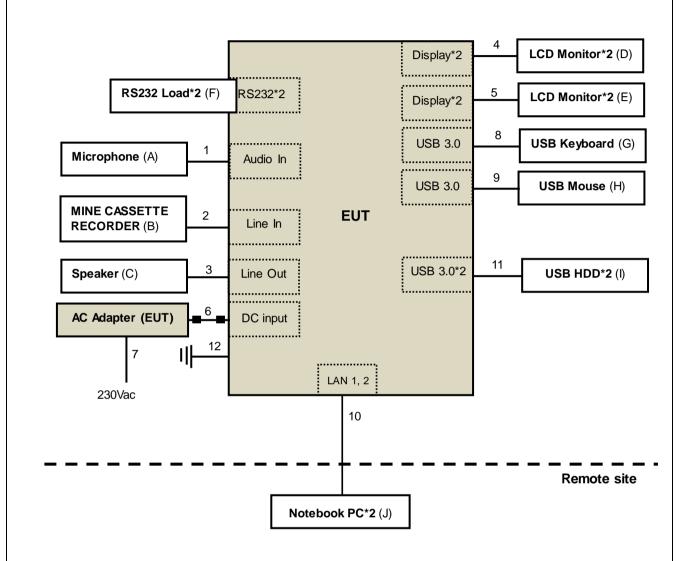
## 4.1 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):





Harmonics & Flicker & Immunity tests:





## 4.2 Configuration of Peripheral Devices and Cable Connections

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
Α.	MICROPHONE	Labtec	mic-333	N/A	N/A	Provided by Lab
В.	MINE CASSETTE RECORDER	PANASONIC	RQ-L11	VVH8EB005745	N/A	Provided by Lab
С.	EARPHONE	PHILIPS	SBC HL145	N/A	N/A	Provided by Lab
	LCD Monitor	ASUS	MG28UQ	J1LMTF114792	FCC DoC Approved	Provided by Lab
D.	LCD Monitor	ASUS	MG28UQ	J1LMTF114786	FCC DoC Approved	Provided by Lab
	LCD Monitor	ASUS	MG28UQ	H8LMTF147971	FCC DoC Approved	Provided by Lab
Ε.	LCD Monitor	ASUS	MX27U	JBLMRS007843	FCC DoC Approved	Provided by Lab
F.	RS232 Load*2	N/A	N/A	N/A	N/A	Supplied by client
G.	USB Keyboard	Dell	KB216t	CN-0W33XP-LO300-7CL-19 09	FCC DoC Approved	Provided by Lab
Η.	USB Mouse	Microsoft	1113	9170528318308	FCC DoC Approved	Provided by Lab
Ι.	Printer	HP	Officejet pro 251dw	N/A	B94SDGOB1191	Provided by Lab
J.	USB HDD	WD	WDBKVX5120PSL	1922MD401387	FCC DoC Approved	Provided by Lab
X	Notebook PC	SONY	SVS151A12P	275548477001024	FCC DoC Approved	Provided by Lab
K.	Notebook PC	ASUS	PU401L	ECNXBC012528528	FCC DoC Approved	Provided by Lab
Notor						

Emission tests (Harmonics & Flicker excluded):

Note:

1. All power cords of the above support units are non-shielded (1.8m).

2. Item K acted as communication partners to transfer data.

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	Audio cable	1	2.5	Ν	0	Provided by Lab
2.	Audio cable	1	1.8	Ν	0	Provided by Lab
3.	Audio cable	1	1.2	Ν	0	Provided by Lab
4.	Display cable	3	1.8	Y	0	Provided by Lab
5.	Display cable	1	1.8	Y	0	Provided by Lab
6.	DC power	1	1.8	Ν	2	Supplied by client
7.	AC power cord	1	1.8	Ν	0	Provided by Lab
8.	USB cable	1	1.8	Y	0	Provided by Lab
9.	USB cable	1	1.8	Y	1	Provided by Lab
10.	USB cable	1	1.8	Y	0	Provided by Lab
11.	USB cable	1	1.0	Y	0	Provided by Lab
12.	GND cable	1	1.8	Ν	0	Provided by Lab
13.	LAN cable	2	10	Ν	0	Provided by Lab (RJ45, Cat.5e)

Note: The core(s) is(are) originally attached to the cable(s).



ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
А.	MICROPHONE	N/A	N/A	N/A	N/A	Provided by Lab
В.	MINE CASSETTE RECORDER	PANASONIC	RQ-L11	VVH8EB005745	N/A	Provided by Lab
C.	SPEAKER	KINYO	KSP-25	N/A	N/A	Provided by Lab
D.	LCD MONITOR	VITA	VT-270JTG2	204270JTFE001	FCC DoC Approved	Provided by Lab
υ.	LCD MONITOR	VITA	VT-270JTG2	204270JTFE002	FCC DoC Approved	Provided by Lab
E.	LCD MONITOR DELL		U2412M	CN-07N2FG-TV100-7B G-039L	NA	Provided by Lab
L.	LCD MONITOR	DELL	U2412M	CN-07N2FG-TV100-975 -095U	NA	Provided by Lab
F.	RS232 Load*2	N/A	N/A	N/A	N/A	Supplied by client
G.	USB Keyboard	HP	SK-2085	NA	NA	Provided by Lab
Н.	USB Mouse	DELL	N889	NA	NA	Provided by Lab
	USB HDD	WD	WDBKVX5120PSL	1922MD400824	FCC DoC Approved	Provided by Lab
Ι.	USB HDD WD WDBKVX512		WDBKVX5120PSL	1922JG400125	FCC DoC Approved	Provided by Lab
J.	Notebook PC	Lenovo	TP00057A	R9-0JMLFS16/01	NA	Provided by Lab
J.	Notebook PC	Lenovo	T470	PF-0QW0NQ	NA	Provided by Lab

### Harmonics, Flicker, Immunity tests:

Note:

1. All power cords of the above support units are non-shielded (1.8m).

2. Item J acted as communication partners to transfer data.

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	Audio cable	1	1.0	Ν	0	Provided by Lab
2.	Audio cable	1	1.8	Ν	0	Provided by Lab
3.	Audio cable	1	1.0	Ν	0	Provided by Lab
4.	Display cable	2	1.8	Y	0	Provided by Lab
5.	Display cable	2	1.8	Y	0	Provided by Lab
6.	DC power	1	1.8	Ν	2	Supplied by client
7.	AC power cord	1	1.8	Ν	0	Provided by Lab
8.	USB cable	1	1.8	Y	0	Provided by Lab
9.	USB cable	1	1.8	Y	0	Provided by Lab
10.	LAN cable	2	10	Ν	0	Provided by Lab
10.				IN	0	(RJ45, Cat.5e)
11.	USB cable	1	1.0	Y	0	Provided by Lab
12.	GND cable	1	2.0	Ν	0	Provided by Lab

Note: The core(s) is(are) originally attached to the cable(s).



### 5 Conducted Emission from the AC Mains Power Port

#### 5.1 Limits

Class A								
Frequency range (MHz)	Coupling device	Detector type / bandwidth	Limits (dBuV)					
0.15 - 0.5			79					
0.5 - 30.0	AMN	Quasi-peak / 9kHz	73					
0.15 - 0.5			66					
0.5 - 30.0		Average / 9kHz	60					
Class B								
Frequency range (MHz)	Coupling device	Detector type / bandwidth	Limits (dBuV)					
0.15 - 0.5			66 - 56					
0.5 - 5		Quasi-peak / 9kHz	56					
5 - 30.0			60					
0.15 - 0.5	AMN		56 - 46					
0.5 - 5		Average / 9kHz	46					
5 - 30.0			50					

Notes: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

### 5.2 Test Instruments

Model No.	Serial No.	Cal. Date	Cal. Due
ESCS 30	100276	Apr. 16, 2020	Apr. 15, 2021
ENV216	101195	May 15, 2020	May 14, 2021
101195	N/A	May 15, 2020	May 14, 2021
3825/2	9504-2359	Jul. 28, 2020	Jul. 27, 2021
NNLK8129	8129229	May 14, 2020	May 13, 2021
NNLK 8121	8121-808	Apr. 10, 2020	Apr. 9, 2021
Cond_V7.3.7.4	NA	NA	NA
5D-FB	Cable-C03-01	Sep. 16, 2020	Sep. 15, 2021
0900510	E1-01-300	Jan. 27, 2021	Jan. 26, 2022
0900510	E1-01-301	Jan. 27, 2021	Jan. 26, 2022
	ESCS 30 ENV216 101195 3825/2 NNLK8129 NNLK 8121 Cond_V7.3.7.4 5D-FB 0900510	ESCS 30     100276       ENV216     101195       101195     N/A       3825/2     9504-2359       NNLK8129     8129229       NNLK 8121     8121-808       Cond_V7.3.7.4     NA       5D-FB     Cable-C03-01       0900510     E1-01-300	ESCS 30100276Apr. 16, 2020ENV216101195May 15, 2020101195N/AMay 15, 20203825/29504-2359Jul. 28, 2020NNLK81298129229May 14, 2020NNLK 81218121-808Apr. 10, 2020Cond_V7.3.7.4NANA5D-FBCable-C03-01Sep. 16, 20200900510E1-01-300Jan. 27, 2021

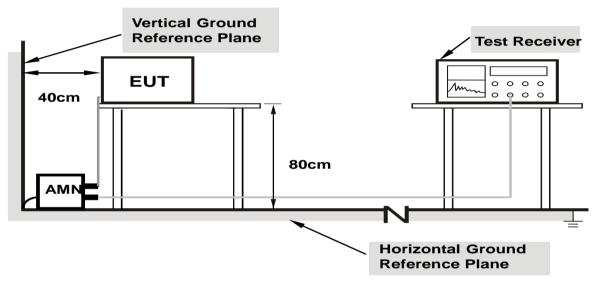
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in Shielded Room No. 3. (Conduction 3)
- 3. The VCCI Site Registration No. C-10274.
- 4. Tested Date: Mar. 30, 2021



### 5.3 Test Arrangement

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through an Artificial Mains Network (AMN). Other support units were connected to the power mains through another AMN. The two AMNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.
- Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



### Note: 1. Support units were connected to second AMN.

2. The distance specified between EUT/AE and other metallic objects is ≥ 0.8 m in the measurement arrangement for table-top EUT.

3. Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



## 5.4 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	110Vac, 60Hz	<b>Environmental Conditions</b>	23°C, 76%RH, 998mbar
Tested by	John Liao	Test Date	2021/3/30
Test Mode	Mode 1		

	Phase Of Power : Line (L)										
No	Frequency	Correction Factor		g Value uV)		n Level uV)		mit SuV)	Mar (d	rgin B)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	
1	0.18125	9.73	41.52	34.62	51.25	44.35	79.00	66.00	-27.75	-21.65	
2	0.23984	9.73	39.97	33.02	49.70	42.75	79.00	66.00	-29.30	-23.25	
3	0.48593	9.74	34.52	27.32	44.26	37.06	79.00	66.00	-34.74	-28.94	
4	0.76328	9.75	35.62	26.58	45.37	36.33	73.00	60.00	-27.63	-23.67	
5	1.62500	9.79	38.32	30.22	48.11	40.01	73.00	60.00	-24.89	-19.99	
6	14.42969	9.95	23.96	16.98	33.91	26.93	73.00	60.00	-39.09	-33.07	

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





Fraguanay Banga		Detector Function &	Quasi-Peak (QP) / Average	
Frequency Range	150kHz ~ 30MHz	<b>Resolution Bandwidth</b>	(AV), 9kHz 23°C, 76%RH, 998mbar	
Input Power	110Vac, 60Hz	<b>Environmental Conditions</b>	23°C, 76%RH, 998mbar	
Tested by	John Liao	Test Date	2021/3/30	
Test Mode	Mode 1			

	Phase Of Power : Neutral (N)										
No	Frequency	Correction Factor	Reading (dB	g Value uV)		n Level uV)		nit uV)	Mar (d	-	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	
1	0.16172	9.73	41.52	31.02	51.25	40.75	79.00	66.00	-27.75	-25.25	
2	0.25156	9.73	41.96	35.32	51.69	45.05	79.00	66.00	-27.31	-20.95	
3	0.48203	9.74	35.32	29.68	45.06	39.42	79.00	66.00	-33.94	-26.58	
4	0.73203	9.75	35.62	22.97	45.37	32.72	73.00	60.00	-27.63	-27.28	
5	1.53516	9.78	36.32	31.20	46.10	40.98	73.00	60.00	-26.90	-19.02	
6	5.68359	9.88	30.25	22.32	40.13	32.20	73.00	60.00	-32.87	-27.80	

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

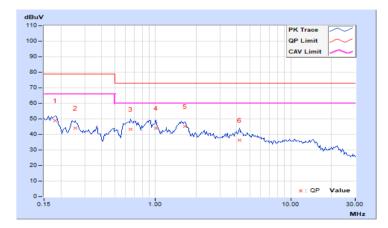




Fraguanay Banga		Detector Function &	Quasi-Peak (QP) / Average
Frequency Range	150kHz ~ 30MHz	<b>Resolution Bandwidth</b>	(AV), 9kHz 23℃, 76%RH, 998mbar
Input Power	230Vac, 50Hz	<b>Environmental Conditions</b>	23°C, 76%RH, 998mbar
Tested by	John Liao	Test Date	2021/3/30
Test Mode	Mode 1		

	Phase Of Power : Line (L)									
No	Frequency	Correction Factor	Reading (dB	g Value uV)		n Level uV)		mit suV)		gin B)
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.18125	9.73	39.26	31.55	48.99	41.28	79.00	66.00	-30.01	-24.72
2	0.25547	9.73	34.52	25.32	44.25	35.05	79.00	66.00	-34.75	-30.95
3	0.65391	9.74	33.52	23.99	43.26	33.73	73.00	60.00	-29.74	-26.27
4	1.00781	9.75	34.23	23.65	43.98	33.40	73.00	60.00	-29.02	-26.60
5	1.65235	9.79	35.32	28.33	45.11	38.12	73.00	60.00	-27.89	-21.88
6	4.16797	9.87	26.56	20.14	36.43	30.01	73.00	60.00	-36.57	-29.99

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





Frequency Range	$150kH7 \approx 30k/H7$	Detector Function &	Quasi-Peak (QP) / Average
		<b>Resolution Bandwidth</b>	(AV), 9kHz
Input Power	230Vac, 50Hz	<b>Environmental Conditions</b>	23°C, 76%RH, 998mbar
Tested by	John Liao	Test Date	2021/3/30
Test Mode	Mode 1		

	Phase Of Power : Neutral (N)										
No	Frequency	Correction Factor		Reading Value Ei (dBuV)		Reading Value Emission Level (dBuV) (dBuV)		Limit (dBuV)		Margin (dB)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	
1	0.18125	9.73	36.11	28.35	45.84	38.08	79.00	66.00	-33.16	-27.92	
2	0.25547	9.73	38.32	29.36	48.05	39.09	79.00	66.00	-30.95	-26.91	
3	0.37656	9.74	33.23	25.39	42.97	35.13	79.00	66.00	-36.03	-30.87	
4	0.63438	9.74	35.62	27.11	45.36	36.85	73.00	60.00	-27.64	-23.15	
5	0.96641	9.75	35.32	23.66	45.07	33.41	73.00	60.00	-27.93	-26.59	
6	1.59766	9.79	35.32	27.15	45.11	36.94	73.00	60.00	-27.89	-23.06	

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





## 6 Asymmetric Mode Conducted Emission at Telecommunication Ports

## 6.1 Limits

Class A							
Frequency range (MHz)	Coupling device	Detector type / bandwidth	Voltage limits (dBuV)	Current limits (dBuA)			
0.15 - 0.5	AAN		97 – 87				
0.5 - 30.0	AAN	Quasi-peak / 9kHz	87	N/A			
0.15 - 0.5	AAN		84-74	IVA			
0.5 - 30.0	AAN	Average / 9kHz	74				
0.15 - 0.5	CVP	Quasi pask / OkHz	97 – 87	53 – 43			
0.5 - 30.0	and current probe	Quasi-peak / 9kHz	87	43			
0.15 - 0.5	CVP		84-74	40 - 30			
0.5 - 30.0	and current probe	Average / 9kHz	74	30			
0.15 - 0.5	Current Probe			53 – 43			
0.5 - 30.0	Current Probe	Quasi-peak / 9kHz	N/A	43			
0.15 - 0.5	Current Droho		IVA	40 - 30			
0.5 - 30.0	Current Probe	Average / 9kHz		30			
		Class B					
Frequency range	Coupling device	Detector type /	Voltage limits	Current limits			
(MHz)		bandwidth	(dBuV)	(dBuA)			
0.15 - 0.5	AAN	Quasi-peak / 9kHz	84 – 74				
0.5 - 30.0		Quasi-peak / Ski iz	74				
			74	Ν/Δ			
0.15 - 0.5	ΔΔΝ		74 74-64	N/A			
0.15 - 0.5 0.5 - 30.0	AAN	Average / 9kHz		N/A			
	AAN		74-64	N/A 40 - 30			
0.5 - 30.0		Average / 9kHz Quasi-peak / 9kHz	74-64 64				
0.5 - 30.0 0.15 - 0.5	CVP	Quasi-peak / 9kHz -	74-64 64 84 – 74	40 - 30			
0.5 - 30.0 0.15 - 0.5 0.5 - 30.0	CVP and current probe		74-64 64 84 – 74 74	40 - 30 30			
0.5 - 30.0 0.15 - 0.5 0.5 - 30.0 0.15 - 0.5	CVP and current probe CVP and current probe	Quasi-peak / 9kHz - Average / 9kHz -	74-64 64 84 – 74 74 74-64	40 - 30 30 30 - 20			
0.5 - 30.0 0.15 - 0.5 0.5 - 30.0 0.15 - 0.5 0.5 - 30.0	CVP and current probe CVP	Quasi-peak / 9kHz -	74-64 64 84 - 74 74 74 64 64	40 - 30 30 30 - 20 20			
0.5 - 30.0 0.15 - 0.5 0.5 - 30.0 0.15 - 0.5 0.5 - 30.0 0.15 - 0.5	CVP and current probe CVP and current probe	Quasi-peak / 9kHz - Average / 9kHz -	74-64 64 84 – 74 74 74-64	40 - 30 30 30 - 20 20 40 - 30			

Notes: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.



## 6.2 Test Instruments

		-		
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	100276	Apr. 16, 2020	Apr. 15, 2021
ROHDE & SCHWARZ Artificial Mains Network (For EUT)	ENV216	101195	May 15, 2020	May 14, 2021
LISN With Adapter (for EUT)	101195	N/A	May 15, 2020	May 14, 2021
EMCO L.I.S.N. (For peripherals)	3825/2	9504-2359	Jul. 28, 2020	Jul. 27, 2021
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK8129	8129229	May 14, 2020	May 13, 2021
SCHWARZBECK Artificial Mains Network (for EUT)	NNLK 8121	8121-808	Apr. 10, 2020	Apr. 9, 2021
Software	Cond_V7.3.7.4	NA	NA	NA
Software	ISN_V7.3.7.4	NA	NA	NA
RF cable (JYEBAO)	5D-FB	Cable-C03.0 1	Sep. 16, 2020	Sep. 15, 2021
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-300	Jan. 27, 2021	Jan. 26, 2022
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-301	Jan. 27, 2021	Jan. 26, 2022
FCC ISN	F-071115-1057-1	20650	Feb. 3, 2021	Feb. 2, 2022

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Shielded Room No. 3. (ISN 3)

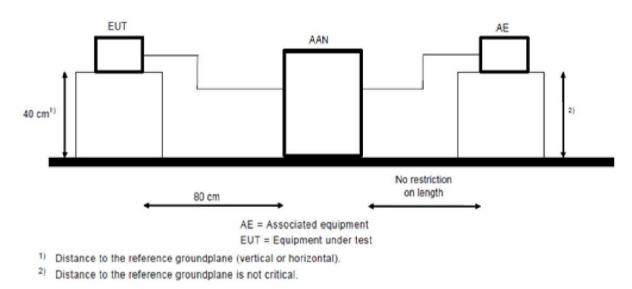
3. The VCCI Site Registration No. T-11651.

4. Tested Date: Mar. 30, 2021

## 6.3 Test Arrangement

#### Method of Using AANs:

- a. The EUT is placed 0.4 meters from the conducting wall of the shielded room and connected to AAN directly to reference ground plane.
- b. If voltage measurement is used, measure voltage at the measurement port of the AAN, correct the reading by adding the AAN voltage division factor, and compare to the voltage limit.
- c. It is not necessary to apply the voltage and the current limit if a AAN is used.
- d. The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.
- Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



### Note: Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

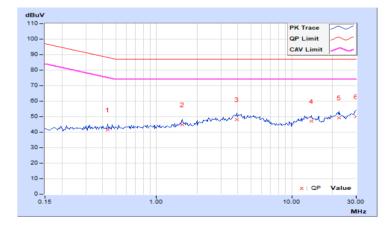


## 6.4 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	<b>Environmental Conditions</b>	23°C, 76%RH, 998mbar
Tested by	John Liao	Test Date	2021/3/30
Test Mode	Mode 1A		

No	Frequency	Correction Factor	n Reading Value Emission Level Limit Margin (dBuV) (dBuV) (dBuV) (dB)				-			
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.43516	9.59	32.02	26.99	41.61	36.58	88.15	75.15	-46.54	-38.57
2	1.55859	9.38	35.32	30.11	44.70	39.49	87.00	74.00	-42.30	-34.51
3	3.91016	9.34	38.65	36.21	47.99	45.55	87.00	74.00	-39.01	-28.45
4	14.05469	9.65	37.23	34.55	46.88	44.20	87.00	74.00	-40.12	-29.80
5	22.43359	10.07	39.32	35.97	49.39	46.04	87.00	74.00	-37.61	-27.96
6	29.99609	10.51	39.32	36.32	49.83	46.83	87.00	74.00	-37.17	-27.17

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

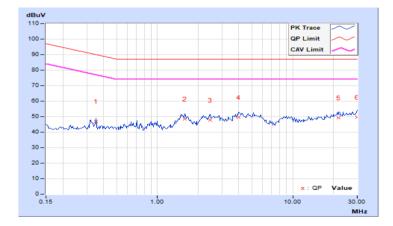




Frequency Range	150kHz ~ 30MHz	Detector Function &	Quasi-Peak (QP) / Average
		<b>Resolution Bandwidth</b>	(AV), 9kHz
Input Power	230Vac, 50Hz	<b>Environmental Conditions</b>	23°C, 76%RH, 998mbar
Tested by	John Liao	Test Date	2021/3/30
Test Mode	Mode 1B		

No	Frequency	Correction Factor		g Value uV)	e Emission Level Limit Margin (dBuV) (dBuV) (dB)				-	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.35313	9.64	37.23	35.21	46.87	44.85	89.89	76.89	-43.02	-32.04
2	1.60156	9.38	38.96	34.25	48.34	43.63	87.00	74.00	-38.66	-30.37
3	2.45703	9.35	38.26	30.05	47.61	39.40	87.00	74.00	-39.39	-34.60
4	3.97656	9.34	40.12	34.99	49.46	44.33	87.00	74.00	-37.54	-29.67
5	21.72266	10.03	39.11	35.65	49.14	45.68	87.00	74.00	-37.86	-28.32
6	29.97656	10.51	39.18	35.88	49.69	46.39	87.00	74.00	-37.31	-27.61

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





## 7 Radiated Emission at Frequencies up to 1GHz

## 7.1 Limits

	Class A		
Frequency range	Distance	Limits	
(MHz)	(m)	(dBuV/m)	
30 - 230	10	40	
230 - 1000	10	47	
30 - 230	2	50	
230 - 1000	3	57	
	Class B		
Frequency range	Distance	Limits	
(MHz)	(m)	(dBuV/m)	
30 - 230	10	30	
230 - 1000	10	37	
30 - 230		40	
230 - 1000	3	47	

Note: The lower limit shall apply at the transition frequencies.

### 7.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	100027	May 19, 2020	May 18, 2021
Schwarzbeck Bilog Antenna	VULB9168	9168-303	Nov. 5, 2020	Nov. 4, 2021
Agilent Preamplifier	8447D	2944A08119	Feb. 18, 2021	Feb. 17, 2022
ADT. Turn Table	TT100	0205	NA	NA
ADT. Tower	AT100	0205	NA	NA
Software	Radiated_V7.6.15.9.5	NA	NA	NA
ADT RF Switches BOX	EMH-011	1001	Oct. 23, 2020	Oct. 22, 2021
Pacific RF cable With 5dB PAD	8D	CABLE-ST2-01	Oct. 23, 2020	Oct. 22, 2021

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Open Site No. 2.

3. The VCCI Site Registration No. R-10237.

4. Tested Date: Mar. 24, 2021

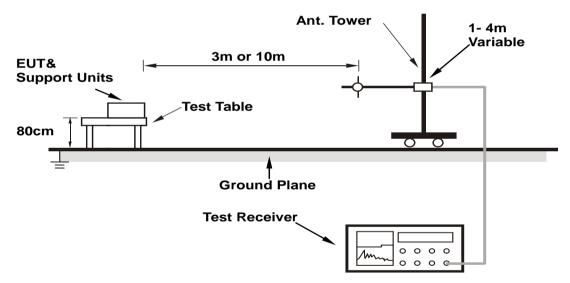


### 7.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.

Note:

- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency up to 1GHz.
- 2. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



Note: Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



## 7.4 Test Results

Frequency Range	30MHz ~ 1GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120kHz
Tested By	Paul Chen	Environmental Conditions	19.0℃, 70.0%RH, 1008mbar
Test Mode	Mode 1	Test Date	2021/3/24

	Antenna Polarity & Test Distance : Horizontal at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	44.24	26.98 QP	40.00	-13.02	4.00 H	228	37.04	-10.06	
2	133.65	31.09 QP	40.00	-8.91	4.00 H	184	41.30	-10.21	
3	166.59	31.78 QP	40.00	-8.22	4.00 H	199	41.10	-9.32	
4	192.01	32.48 QP	40.00	-7.52	4.00 H	310	44.57	-12.09	
5	212.09	30.94 QP	40.00	-9.06	4.00 H	67	43.07	-12.13	
6	250.00	32.69 QP	47.00	-14.31	3.73 H	225	42.49	-9.80	
7	380.46	33.27 QP	47.00	-13.73	3.16 H	331	39.22	-5.95	
8	480.02	32.58 QP	47.00	-14.42	2.07 H	176	36.52	-3.94	
9	635.29	30.92 QP	47.00	-16.08	1.34 H	38	31.28	-0.36	
10	999.98	36.49 QP	47.00	-10.51	1.00 H	187	29.89	6.60	

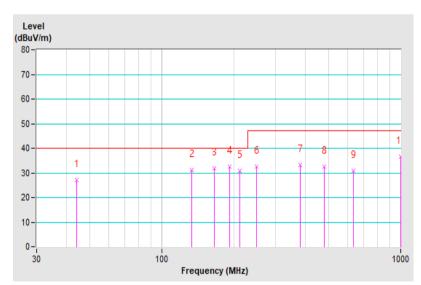
## Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





Frequency Range	30MHz ~ 1GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120kHz
Tested By	Paul Chen	Environmental	19.0℃, 70.0%RH,
Tested By		Conditions	1008mbar
Test Mode	Mode 1	Test Date	2021/3/24

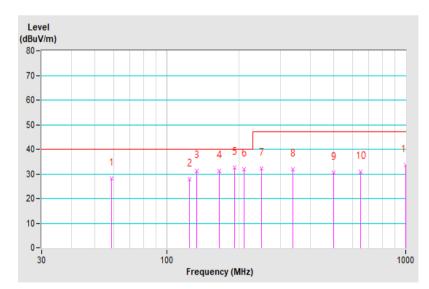
	Antenna Polarity & Test Distance : Vertical at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	58.89	28.16 QP	40.00	-11.84	1.49 V	255	38.70	-10.54	
2	124.99	27.86 QP	40.00	-12.14	1.00 V	320	39.05	-11.19	
3	133.34	31.12 QP	40.00	-8.88	1.00 V	317	41.33	-10.21	
4	166.65	31.09 QP	40.00	-8.91	1.00 V	254	40.41	-9.32	
5	192.01	32.49 QP	40.00	-7.51	1.00 V	180	44.58	-12.09	
6	210.13	31.83 QP	40.00	-8.17	1.00 V	169	44.05	-12.22	
7	250.00	32.13 QP	47.00	-14.87	1.00 V	196	41.93	-9.80	
8	336.08	31.98 QP	47.00	-15.02	1.00 V	67	38.81	-6.83	
9	499.99	30.65 QP	47.00	-16.35	1.00 V	222	34.13	-3.48	
10	646.32	30.69 QP	47.00	-16.31	3.46 V	253	30.99	-0.30	
11	999.98	33.64 QP	47.00	-13.36	2.19 V	39	27.04	6.60	

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





### 8 Radiated Emission at Frequencies above 1GHz

#### 8.1 Limits

Class A						
Frequency range (MHz)	Distance (m)	Detector type	Limits (dBuV/m)			
1000 - 3000		Average	56			
3000 - 6000	3	Average	60			
1000 - 3000	3	Peak	76			
3000 - 6000		Реак	80			
	Clas	ss B				
Frequency range (MHz)	Distance (m)	Detector type	Limits (dBuV/m)			
1000 - 3000		Average	50			
3000 - 6000	2	Average	54			
1000 - 3000	3	Peak	70			
3000 - 6000		reak	74			

Note: The lower limit shall apply at the transition frequencies.

### Required highest frequency for radiated measurement

Highest internal frequency (F <sub>x</sub> ) (MHz)	Highest measured frequency
$F_x \leq 108 \text{ MHz}$	1 GHz
108 MHz $<$ Fx $\leq$ 500 MHz	2 GHz
500 MHz $< F_x \leq 1 \text{ GHz}$	5 GHz
$F_x > 1 \text{ GHz}$	5 x $F_x$ up to a maximum of 6 GHz

NOTE 1 For FM and TV broadcast receivers, F<sub>x</sub> is determined from the highest frequency generated or used excluding the local oscillator and tuned frequencies.

NOTE 2 F<sub>x</sub> is highest fundamental frequency generated or used within the EUT or highest frequency at which it operates.

NOTE 3 For outdoor units of home satellite receiving systems highest measured frequency shall be 18 GHz. Where  $F_x$  is unknown, the radiated emission measurements shall be performed up to 6 GHz.



## 8.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Agilent Spectrum	E4446A	MY51100009	Jun. 23, 2020	Jun. 22, 2021
Agilent Test Receiver	N9038A	MY50010135	May 29, 2020	May 28, 2021
EMCI Preamplifier	EMC0126545	980076	Feb. 19, 2021	Feb. 18, 2022
MITEQ Preamplifier	AMF-6F-260400-33-8P	892164	Feb. 19, 2021	Feb. 18, 2022
EMCI Preamplifier	EMC184045B	980235	Feb. 19, 2021	Feb. 18, 2022
ETS Preamplifier	3117-PA	00215857	Nov. 23, 2020	Nov. 22, 2021
Schwarzbeck Horn Antenna	BBHA-9170	212	Nov. 22, 2020	Nov. 21, 2021
EMCO Horn Antenna	3115	9312-4192	Nov. 22, 2020	Nov. 21, 2021
Max Full. Turn Table & Tower	MF7802	MF780208103	NA	NA
Software	Radiated_V8.7.08	NA	NA	NA
SUHNER RF cable With 3/4dB PAD	SF102	Cable-CH7-3.6m	Jul. 9, 2020	Jul. 8, 2021
MICRO-TRONICS Notch filter	BRC50703-01	010	May 29, 2020	May 28, 2021
MICRO-TRONICS Band Pass Filter	BRM17690	005	May 29, 2020	May 28, 2021

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The 3dB beamwidth of the horn antenna is minimum 40 degree (or w = 2.18m at 3m distance) for 1~6 GHz.

3. The test was performed in Chamber No. 7.

4. The VCCI Site Registration No. G-10039

5. Tested Date: Mar. 25, 2021

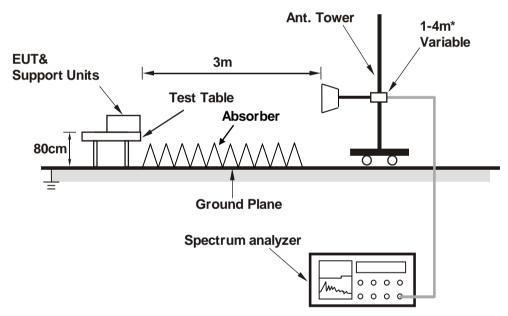


#### 8.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The spectrum analyzer system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

Note:

- The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.
- 2. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



Note: Cable on the RGP must to be insulated.

\* :depends on the EUT height and the antenna 3dB beamwidth both.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



## 8.4 Test Results

Frequency Range	1GHz ~ 6GHz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested By	ED. Lin	Environmental Conditions	20.0℃, 70.0%RH, 1010mbar
Test Mode	Mode 1	Test Date	2021/3/25

	Antenna Polarity & Test Distance : Horizontal at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	1399.97	48.22 PK	76.00	-27.78	1.00 H	207	51.81	-3.59	
2	1399.97	37.98 AV	56.00	-18.02	1.00 H	207	41.57	-3.59	
3	1592.00	45.91 PK	76.00	-30.09	1.00 H	243	49.11	-3.20	
4	1592.00	42.91 AV	56.00	-13.09	1.00 H	243	46.11	-3.20	
5	1967.00	46.28 PK	76.00	-29.72	1.50 H	66	46.23	0.05	
6	1967.00	33.03 AV	56.00	-22.97	1.50 H	66	32.98	0.05	
7	2939.25	60.33 PK	76.00	-15.67	1.54 H	101	59.19	1.14	
8	2939.25	41.70 AV	56.00	-14.30	1.54 H	101	40.56	1.14	
9	4008.97	47.37 PK	80.00	-32.63	1.50 H	125	43.04	4.33	
10	4008.97	34.72 AV	60.00	-25.28	1.50 H	125	30.39	4.33	
11	4666.40	48.64 PK	80.00	-31.36	1.00 H	191	44.04	4.60	
12	4666.40	39.17 AV	60.00	-20.83	1.00 H	191	34.57	4.60	

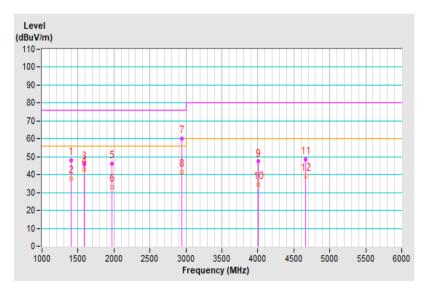
## Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





Eroqueney Benge	1GHz ~ 6GHz	<b>Detector Function &amp;</b>	Peak (PK) / Average (AV),
Frequency Range		<b>Resolution Bandwidth</b>	1MHz
Tested By	ED. Lin	Environmental	20.0°C, 70.0%RH,
		Conditions	1010mbar
Test Mode	Mode 1	Test Date	2021/3/25

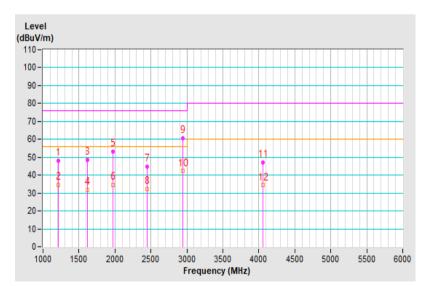
	Antenna Polarity & Test Distance : Vertical at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	1211.32	48.02 PK	76.00	-27.98	1.46 V	286	51.80	-3.78	
2	1211.32	34.65 AV	56.00	-21.35	1.42 V	286	38.43	-3.78	
3	1614.46	48.54 PK	76.00	-27.46	1.53 V	257	51.68	-3.14	
4	1614.46	31.88 AV	56.00	-24.12	1.56 V	257	35.02	-3.14	
5	1975.97	53.29 PK	76.00	-22.71	1.00 V	229	53.22	0.07	
6	1975.97	34.55 AV	56.00	-21.45	1.00 V	229	34.48	0.07	
7	2444.86	44.89 PK	76.00	-31.11	1.81 V	187	45.33	-0.44	
8	2444.86	32.12 AV	56.00	-23.88	1.81 V	187	32.56	-0.44	
9	2939.75	60.70 PK	76.00	-15.30	2.00 V	116	59.55	1.15	
10	2939.75	42.23 AV	56.00	-13.77	2.00 V	116	41.08	1.15	
11	4059.93	46.98 PK	80.00	-33.02	2.35 V	360	42.71	4.27	
12	4059.93	34.32 AV	60.00	-25.68	2.35 V	360	30.05	4.27	

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





### 9 Harmonics Current Measurement

#### 9.1 Limits

Limits for	or Class A equipment		Limits for Class D equi	pment
Harmonic	Max. permissible	Harmonic	Max. permissible	Max. permissible
Order	harmonics current	Order	harmonics current per	harmonics current
n	A	n	watt mA/W	A
C	Odd harmonics		Odd Harmonics onl	у
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
15≦n≦39	0.15 x 15/n	15≦n≦39	3.85/n	0.15 x 15/n
E	ven harmonics			
2	1.08			
4	0.43			
6	0.30			
8≦n≦40	0.23 x 8/n			

Notes: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.

 According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

#### 9.2 Classification of Equipment

Class A	Class B	Class C	Class D
Balanced three-phase equipment;	Portable tools;	Lighting	Equipment having a specified
Household appliances excluding	Arc welding	equipment.	power less than or equal to 600
equipment as Class D;	equipment which is		W of the following types:
Tools excluding portable tools;	not professional		Personal computers and
Dimmers for incandescent lamps;	equipment.		personal computer monitors;
Audio equipment;			Television receivers;
Equipment not specified in one of the			Refrigerators and freezers
three other classes.			having one or more
			variable-speed drives to control
			compressor motor(s).

#### 9.3 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Profline 2105	32A00983 & 1639A01863	Sep. 16, 2020	Sep. 15, 2021
Software	CTS 4	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in EMS Room No. 1.

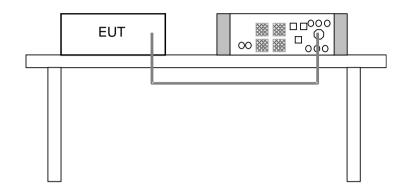
3. According to IEC 61000-4-7: 2002, the time window shall be synchronized with each group of 10 or 12 cycles (200 ms)for power frequency of 50 or 60Hz.

4. Tested Date: Apr. 1, 2021



#### 9.4 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



## 9.5 Test Results

Fundamental Voltage/Ampere	230.54Vrms/ 0.427Arms	Power Frequency	50.00Hz
Power Consumption	84.2W	Power Factor	0.879
Enviromental Conditions	24°C, 70% RH	Tested by	Thomas Cheng
Test Mode	Mode 1	Test Date	2021/4/1

Harm#	Harms (avg) (A)	100% Limit (A)	Harms (max) (A)	150% Limit (A)	Test Result
3	0.114	0.286	0.131	0.430	Pass
5	0.041	0.160	0.046	0.240	Pass
7	0.018	0.084	0.020	0.126	Pass
9	0.009	0.042	0.011	0.063	Pass
11	0.011	0.029	0.013	0.044	Pass
13	0.008	0.025	0.008	0.038	Pass
15	0.007	0.022	0.008	0.033	Pass
17	0.007	0.019	0.009	0.029	Pass
19	0.004	0.017	0.006	0.026	Pass
21	0.005	0.015	0.006	0.023	Pass
23	0.005	0.014	0.006	0.021	Pass
25	0.005	0.013	0.006	0.019	Pass
27	0.006	0.012	0.007	0.018	Pass
29	0.002	0.011	0.005	0.017	Pass
31	0.005	0.010	0.007	0.016	Pass
33	0.005	0.010	0.007	0.015	Pass
35	0.004	0.009	0.005	0.014	Pass
37	0.002	0.009	0.004	0.013	Pass
39	0.003	0.008	0.004	0.013	Pass

Note: Dynamic limits were applied for this test. The highest harmonics values in the above table may not occur at the same window as the maximum harmonics/limit ratio.



#### 10 Voltage Fluctuations and Flicker Measurement

#### 10.1 Limits

Test item	Limit	Note
P <sub>st</sub>	1.0	P <sub>st:</sub> short-term flicker severity.
Pit	0.65	Ptt: long-term flicker severity.
T <sub>max</sub> (ms)	500	$T_{max:}$ maximum time duration during the observation period that the voltage deviation d(t) exceeds the limit for d <sub>c</sub> .
d <sub>max</sub> (%)	4	d <sub>max:</sub> maximum absolute voltage change during an observation period.
d <sub>c</sub> (%)	3.3	d <sub>c</sub> : maximum steady state voltage change during an observation period.

#### 10.2 Test Instruments

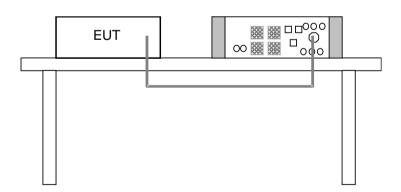
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Profline 2105	32A00983 & 1639A01863	Sep. 16, 2020	Sep. 15, 2021
Software	CTS 4	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 1.
- 3. Tested Date: Apr. 1, 2021

#### 10.3 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



### 10.4 Test Results

Fundamental Voltage/Ampere	230.54Vrms/ 0.427Arms	Power Frequency	50.00Hz
Observation (T <sub>p</sub> )	10 min.	Power Factor	0.879
Enviromental Conditions	24°C, 70% RH	Tested by	Thomas Cheng
Test Mode	Mode 1	Test Date	2021/4/1

Test Parameter	Measurement Value	Limit	Remarks
P <sub>st</sub>	0.319	1.00	Pass
Pit	0.139	0.65	Pass
T <sub>max</sub> (ms)	0	500	Pass
d <sub>max</sub> (%)	0	4	Pass
d <sub>c</sub> (%)	0	3.3	Pass

Note: (1) Pst means short-term flicker indicator.

(2) P<sub>lt</sub> means long-term flicker indicator.

(3) T<sub>max</sub> means accumulated time value of d(t) with a deviation exceeding 3.3 %.
(4) d<sub>max</sub> means maximum relative voltage change.

(5)  $d_c$  means maximum relative steady-state voltage change.



# 11 General Immunity Requirements

Reference standard	Test specification	Performance Criterion
EN/IEC 61000-4-2 ESD	Enclosure port: ±8kV Air discharge, ±4kV Contact discharge	В
EN/IEC 61000-4-3 RS	Enclosure port: Swept freq. test : 80-1000 MHz, 3V/m, 80% AM (1kHz), Spot freq. test : 1800, 2600, 3500, 5000 MHz (±1 %), 3V/m, 80% AM (1kHz)	A
EN/IEC 61000-4-4	Analogue/digital data ports (cable length > 3m): xDSL equipment: ±0.5kV, 5/50 (t <sub>r</sub> /t <sub>w</sub> ) ns, 100kHz others: ±0.5kV, 5/50 (t <sub>r</sub> /t <sub>w</sub> ) ns, 5kHz	
EFT	DC network power port(cable length > 3m): $\pm 0.5$ kV, 5/50 (t <sub>r</sub> /t <sub>w</sub> ) ns, 5kHz AC mains power ports: $\pm 1.0$ kV, 5/50 (t <sub>r</sub> /t <sub>w</sub> ) ns, 5kHz	В
EN/IEC 61000-4-5 Surge	Analogue/digital data ports (direct to outdoor cables): Port type: unshielded symmetrical 10/700(5/320) (T <sub>f</sub> /T <sub>d</sub> ) μs, w/o primary protectors (line to ground): ±1.0kV, or with primary protectors (line to ground): ±1.0kV, ±4.0kV Port type: coaxial or shielded 1.2/50 (8/20) (T <sub>f</sub> /T <sub>d</sub> ) μs, shield to ground: ±0.5kV	С
Ŭ	DC network power port (direct to outdoor cables): 1.2/50(8/20) (T <sub>f</sub> /T <sub>d</sub> ) μs, Line to ground: ±0.5kV AC mains power ports: 1.2/50(8/20) (T <sub>f</sub> /T <sub>d</sub> ) μs,	В
	Line to ground: ±2kV	В
EN/IEC 61000-4-6 CS	Analogue/digital data ports (cable length > 3m) ; DC network power ports (cable length > 3m) ; AC mains power ports 0.15-10 MHz, 3V, 80% AM (1kHz), 10-30 MHz, 3V-1V, 80% AM (1kHz), 30-80 MHz, 1V, 80% AM (1kHz)	A
EN/IEC 61000-4-8 PFMF	Enclosure port: 50 or 60 Hz, 1A/m	А
EN/IEC 61000-4-11	AC mains power ports: (at 50 Hz) Voltage Dips: <5% residual – 0.5 cycle 70% residual – 25 cycles	B C
Voltage Dips & Interruptions	AC mains power ports: Voltage Interruptions: <5% residual – 250 cycles	С

### 11.1 Performance Criteria

#### General Performance Criteria

#### Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Performance criterion B

After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

#### **Product Specific Performance Criteria**

The particular performance criteria which are specified in the normative annexes of EN 55035 take precedence over the corresponding parts of the general performance criteria. Where particular performance criteria for specific functions are not given, then the general performance criteria shall apply.

### 12 Electrostatic Discharge Immunity Test (ESD)

#### 12.1 Test Specification

Basic Standard:	EN/IEC 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Discharge Voltage:	Air Discharge: ±2, ±4, ±8kV (Direct)
	Contact Discharge: ±2, ±4kV (Indirect/ Direct)
Number of Discharge:	Air – Direct: 10 discharges per location (each polarity)
	Contact – Direct & Indirect: 10 discharges per location (each polarity)
Discharge Mode:	Single Discharge
Discharge Period:	1-second minimum

#### 12.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
KeyTek, ESD Simulator	MZ-15/EC	0401299	Oct. 7, 2020	Oct. 6, 2021

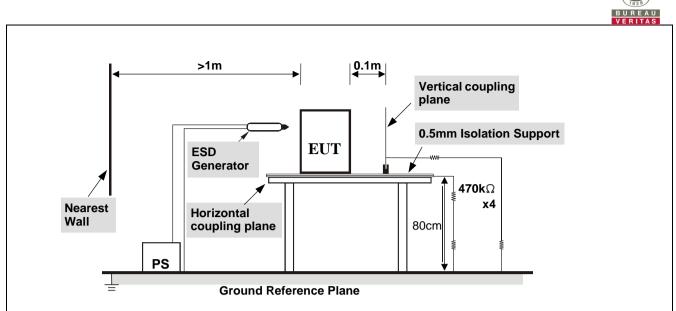
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in ESD Room No. 3.
- 3. Tested Date: Apr. 6, 2021

#### 12.3 Test Arrangement

The basic test procedure was in accordance with EN/IEC 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.



#### TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the **G**round **R**eference **P**lane. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940k $\Omega$  total impedance. The equipment under test, was installed in a representative system as described in section 7 of

EN/IEC 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



#### 12.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Sean Chou
Environmental conditions	23 °C, 42% RH 1012 mbar Test Date 2		2021/4/6
Test mode	Mode 1		

	Test Results of Direct Application							
Discharge Level (kV)								
2,4	+/-	1-5	Note 1	NA	A			
2,4,8	+/-	8~11	NA	Note 1	А			
2,4	+/-	6,7	NA	Note 1	A			
8	+/-	6,7	NA	Note 2	В			

Description of test points of direct application: Please refer to following page for representative mark only.

	Test Results of Indirect Application							
	Discharge Polarity Test Deint Horizontal Vertical Coupling Performance							
Level (kV) (+/-) Test Point Coupling Plane Plane				Criterion				
	2, 4 +/- Four Sides Note 1 Note 1 A							
_								

Description of test points of indirect application:

1. Front side

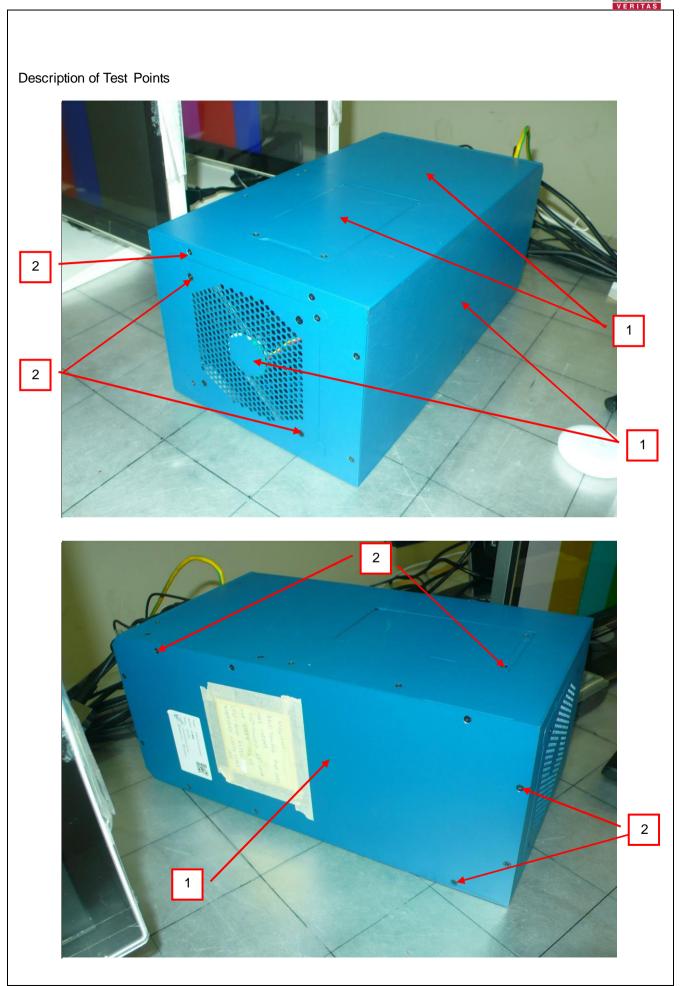
3. Right side

4. Left side

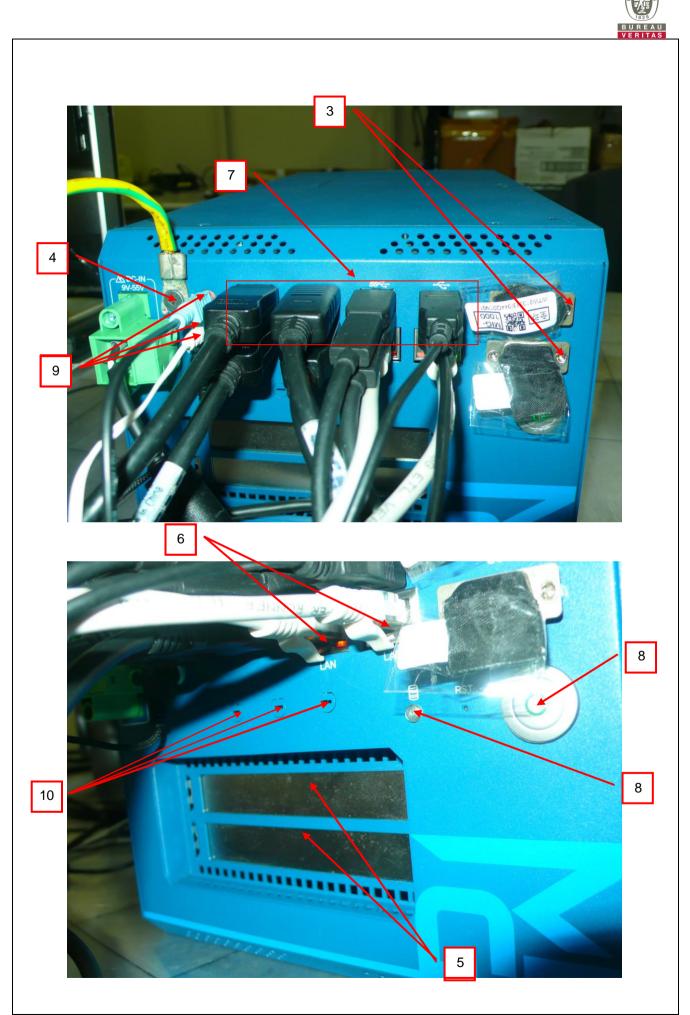
Note: 1. The EUT function was correct during the test.

2. Rear side

2. The image on the screen flickered during the test, but self-recoverable after the test.



Report No.: CEBDBO-WTW-P21030872









#### 13 Radiated, Radio-frequency, Electromagnetic Field Immunity Test (RS)

#### 13.1 Test Specification

Basic Standard:	EN/IEC 61000-4-3
Swept Frequency Range:	80 MHz - 1000 MHz
Spot Frequencies:	1800, 2600, 3500, 5000 MHz (±1 %)
Field Strength:	3 V/m
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Polarity of Antenna:	Horizontal and Vertical
Antenna Height:	1.5m
Dwell Time:	3 seconds

### 13.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
AgilentSignal Generator	E8257D	MY48050465	Jun. 8, 2020	Jun. 7, 2021
BONN RF Amplifier	BSA 0125-800	1912556	NA	NA
TESTQAmplifier	CBA 1G-275	T44344	NA	NA
AR RF Amplifier	35S4G8AM4	0326094	NA	NA
AR RF Amplifier	100S1G4M3	0329249	NA	NA
AR Controller	SC1000M3	305910	NA	NA
ARLog-Periodic Antenna	AT6080	0329465	NA	NA
BOONTON RF Voltage Meter	4232A	10180	May 29, 2020	May 28, 2021
BOONTON Power Sensor	51011-EMC	34152	May 29, 2020	May 28, 2021
BOONTON Power Sensor	51011-EMC	34153	May 29, 2020	May 28, 2021
EMCO BiconiLog Antenna	3141	1001	NA	NA
ARHigh Gain Antenna	AT4010	0329800	NA	NA
SchwarzbeckLOG ANTENNA	Stlp 9149	9149-260	NA	NA
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	Feb. 4, 2021	Feb. 3, 2022
Software	RS_V7.6	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in RS Room No.2.

3. The transmit antenna was located at a distance of 3 meters from the EUT.

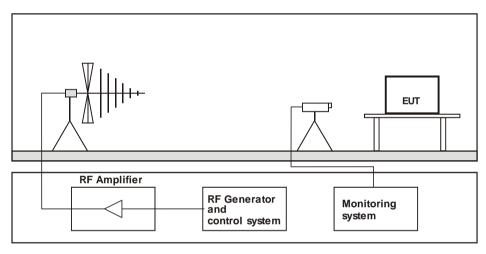
4. Tested Date: Apr. 6, 2021



#### 13.3 Test Arrangement

The test procedure was in accordance with EN/IEC 61000-4-3.

- a. The testing was performed in a fully anechoic chamber.
- b. The swept frequency range is from 80 MHz to 1000 MHz and the spot frequencies are 1800, 2600, 3500, 5000 MHz (±1 %), with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The dwell time of the amplitude modulated carrier was applied in 3 s at each of the frequencies during the scan. The sensitive frequencies (e.g. clock frequencies or frequencies identified by the manufacturer or obtained as outcome of the test) shall be analyzed in addition to the stepped frequencies.
- d. The field strength level was 3 V/m.
- e. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



#### Table-top Equipment

The EUT installed in a representative system as described in section 7 of EN/IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



### 13.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Sean Chou
Environmental conditions	22 °C, 69% RH	Test Date	2021/4/6
Test mode	Mode 1		

Frequency (MHz)	Polarity	Azimuth(°)	Appli	ed Field Strength	Observation	Performance	Remark
	rolanty		(V/m)	Modulation	Observation	Criterion	I CILIAI K
		0	3	80% AM (1kHz)	Note	A	
80 - 1000	V&H	90	3	80% AM (1kHz)	Note	A	
80 - 1000	VOIT	180	3	80% AM (1kHz)	Note	A	
		270	3	80% AM (1kHz)	Note	A	
		0	3	80% AM (1kHz)	Note	A	-
1800, 2600, 3500,	\/ <b>0</b> Ц	90	3	80% AM (1kHz)	Note	A	
5000 MHz (±1 %)	V&H	180	3	80% AM (1kHz)	Note	A	
		270	3	80% AM (1kHz)	Note	A	
		0	3	80% AM (1kHz)	Note	A	
80 - 1000	V&H	90	3	80% AM (1kHz)	Note	A	
00 - 1000	VαΠ	180	3	80% AM (1kHz)	Note	A	Audio
		270	3	80% AM (1kHz)	Note	A	Audio
		0	3	80% AM (1kHz)	Note	A	output function
1800, 2600, 3500, 5000 MHz (±1 %)	V&H	90	3	80% AM (1kHz)	Note	A	TUNCTON
	VQU	180	3	80% AM (1kHz)	Note	A	
		270	3	80% AM (1kHz)	Note	А	

Note: The EUT function was correct during the test. Remark: Audio out function (Audio out) electrical reference level pass.

### 14 Electrical Fast Transient/Burst Immunity Test (EFT)

### 14.1 Test Specification

Basic Standard:	EN/IEC 61000-4-4
Test Voltage:	Analogue/digital data port (cable length > 3m): ±0.5kV DC network power port (cable length > 3m): NA AC mains power port: ±1kV
Impulse Repetition Frequency:	100kHz : applicable only to xDSL port 5kHz : others
Impulse Wave Shape :	5/50 ns
Burst Duration:	0.75 ms for 100kHz Repetition Frequency 15 ms for 5kHz Repetition Frequency
Burst Period:	300 ms
Test Duration:	1 min.

## 14.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Haefely, EFT Generator	PEFT 4010	154954	Apr. 20, 2020	Apr. 19, 2021
Haefely, Capacitive Clamp	IP4A	155173	Apr. 20, 2020	Apr. 19, 2021

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

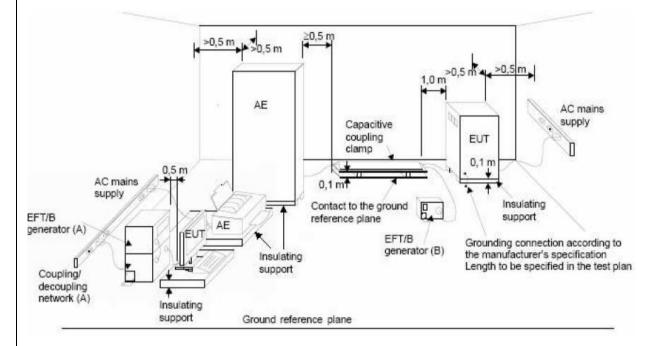
2. The test was performed in EFT Room.

3. Tested Date: Apr. 1, 2021



#### 14.3 Test Arrangement

- a. Both positive and negative polarity discharges were applied.
- b. The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- c. The duration time of each test sequential was 1 minute.
- d. The transient/burst waveform was in accordance with EN/IEC 61000-4-4, 5/50 ns.



### NOTE:

- (A) location for supply line coupling
- (B) location for signal lines coupling

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



### 14.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Thomas Cheng
Environmental conditions	22 °C, 69% RH	Test Date	2021/4/1
Test mode	Mode 1		

# Input DC/AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
1	L1	+/-	Note	A
1	L2	+/-	Note	A
1	PE	+/-	Note	A
1	L1-L2-PE	+/-	Note	A

Signal / telecommunication port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
0.5	LAN 1	+/-	Note	A

Note: The EUT function was correct during the test.

#### 15 Surge Immunity Test

#### 15.1 Test Specification

•	
Basic Standard: Wave-Shape:	EN/IEC 61000-4-5 Analogue/digital data ports (direct to outdoor cables*): Port type: unshielded symmetrical 10/700 µs Open Circuit Voltage 5/320 µs Short Circuit Current
	Port type: coaxial or shielded 1.2/50 μs Open Circuit Voltage 8/20 μs Short Circuit Current
	DC network power port (direct to outdoor cables*): 1.2/50 μs Open Circuit Voltage 8/20 μs Short Circuit Current
	AC mains power port: 1.2/50 μs Open Circuit Voltage 8/20 μs Short Circuit Current
Test Voltage:	Analogue/digital data ports (direct to outdoor cables): Port type: unshielded symmetrical** w/o primary protectors (line to ground): N/A with primary protectors (line to ground): N/A Port type: coaxial or shielded shield to ground: N/A
	DC network power port: N/A
	AC mains power ports: Line to line : ±0.5kV, ±1kV Line to ground : ±0.5kV, ±1kV, ±2kV
AC Phase Angle (degree):	90° / 270°
Pulse Repetition Rate:	1 time / 20 sec.
Number of Tests:	5 positive and 5 negative at selected points

\* This test is only applicable only to ports, which according to the manufacturer's specification, may connect directly to outdoor cables.

\*\* For ports where primary protection is intended, surges are applied at voltages up to 4 kV with the primary protectors. Otherwise the 1 kV test level is applied without primary protection in place.

#### 15.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
TESEQ, Surge Simulator	NSG 3060	1572	May 12, 2020	May 11, 2021
TESEQ, CDN	CDN 3083-100	1215	May 12, 2020	May 11, 2021
Coupling Decoupling Network	CDN-UTP8	045	Aug. 18, 2020	Aug. 17, 2021
TESEQ Coupling Decoupling Network	CDN HSS-2	41009	May 12, 2020	May 11, 2021
TESEQ Coupling Decoupling Network	CDN 118-T8	40386	Sep. 8, 2020	Sep. 7, 2021
TESEQ CDN for Unshielded Unsymmetrical Signal & Data Lines	CDN117	40144	Sep. 8, 2020	Sep. 7, 2021

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in EMS Room No. 2.

3. Tested Date: Apr. 8, 2021

#### 15.3 Test Arrangement

a. EUT Power ports:

The surge shall be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling network shall not exceed 2 meters in length.

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.

#### b. Analogue/digital data ports:

• Unshielded unsymmetrical interconnection lines:

The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling network shall not exceed 2 meters in length.

• Unshielded symmetrical interconnection lines:

For symmetrical interconnection lines and high-speed interconnection lines, the CDN shall be selected to match the number of lines/pairs existing in the cable. If coupling arrestors are use, test levels below the ignition point of the coupling arrestor cannot be specified.

The interconnection line between the EUT and the coupling/decoupling networks shall not exceed 2 meters in length.

In order to avoid the coupling and decoupling capacitors having a filtering effect on the data transfer, a balanced high frequency design associating the coupling capacitors with coupling chokes is required. Where normal functioning of high speed communications lines cannot be achieved because of the impact of the CDN on the EUT, product committees should specify appropriate operation or that no surge immunity test is required.

• Shielded lines:

The EUT is isolated from ground and the surge is applied to its metallic enclosure; the termination (or auxiliary equipment) at the port(s) under test is grounded. This test applies to equipment with one or more shielded cables.

The length of the cable between the port(s) under test and the device attached to the other end of the cable shall be:

- 20 m (preferred length) or,
- the shortest length over 10 m, where the manufacturer provides pre-assembled cables used in actual installations.

No test shall be required for cables which according to the manufacturer's specification are  $\leq 10$  m.

Rules for application of the surge to shielded lines:

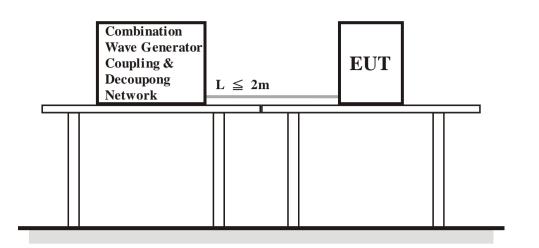
- a) Shields grounded at both ends:
- the test shall be carried out.

The test level is applied on shields with a 2  $\Omega$  generator source impedance and with the 18  $\mu$ F capacitor.

- b) Shields grounded at one end:
- the test shall be carried out according to unshielded unsymmetrical interconnection lines or unshielded symmetrical interconnection lines because the shield does not provide any protection against surges induced by magnetic fields.

For EUTs which do not have metallic enclosures, the surge is applied directly to the shielded cable at the EUT side.





For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

#### 15.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Bernie Lu
Environmental conditions	23 °C, 64% RH	Test Date	2021/4/8
Test mode	Mode 1		

Input AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
0.5, 1	L1-L2	+/-	Note	A
0.5, 1, 2	L1-PE	+/-	Note	A
0.5, 1, 2	L2-PE	+/-	Note	A

Note: The EUT function was correct during the test.

# 16 Immunity to Conducted Disturbances Induced by RF Fields (CS)

# 16.1 Test Specification

Basic Standard:	EN/IEC 61000-4-6
Frequency Range:	0.15 MHz - 80 MHz
Voltage Level:	0.15 MHz - 10 MHz: 3V
	10 MHz - 30 MHz: 3-1 V
	30 MHz - 80 MHz: 1V
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Dwell Time	3 seconds



### 16.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ	SML03	101801	Jan. 13, 2021	Jan. 12, 2022
Signal Generator				•
Digital Sweep Function Generator	8120	984801	NA	NA
AR Power Amplifier	75A250AM1	306331	NA	NA
FCC Coupling Decoupling Network	FCC-801-M2-16A	01047	Jun. 18, 2020	Jun. 17, 2021
FISCHER CUSTOM COMMUNICATIONS EM Injection Clamp	F-203I-23mm	455	NA	NA
FISCHER CUSTOM COMMUNICATIONS Current Injection Clamp	F-120-9A	361	Jul. 30, 2020	Jul. 29, 2021
B&K Ear Simulator	4185	2553594	NA	NA
EM TEST Coupling Decoupling Network	CDN M1/32A	306508	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T800	34428	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T800	29459	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T8-230	56641	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN T8-230	56642	Feb. 25, 2021	Feb. 24, 2022
R&S Power Sensor	NRV-Z5	837878/039	Nov. 10, 2020	Nov. 9, 2021
R&S Power Meter	NRVD	837794/040	Nov. 10, 2020	Nov. 9, 2021
TESEQ Coupling Decoupling Network	CDN M232	37702	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN M332	41258	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN M332	41256	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T8-10	40376	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T8-230	56643	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN S200	53490	May 27, 2020	May 26, 2021
TESEQ Coupling Decoupling Network	CDN S400	52115	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T400A	49918	Feb. 25, 2021	Feb. 24, 2022
FCC Coupling Decoupling Network	FCC-801-M5-50A	100018	Jan. 19, 2021	Jan. 18, 2022
TESEQ Coupling Decoupling Network	CDN T2A-10	54942	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN S751A	56435	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN ST08A	56527	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN ST08A	56525	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN M432S	56519	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN S751A	56436	Feb. 25, 2021	Feb. 24, 2022
Software	CS_V7.4.2	NA	NA	NA

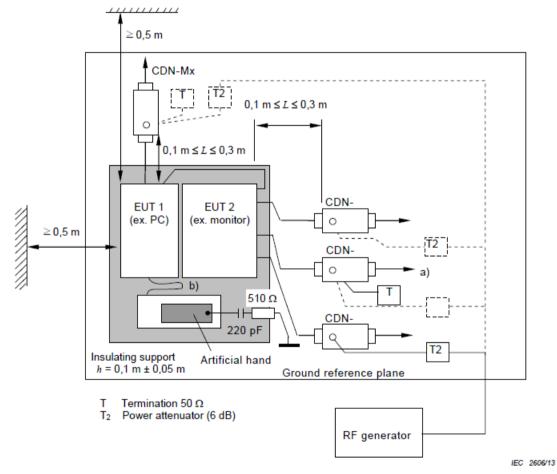
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in CS Room No. 1.
- 3. Tested Date: Apr. 7, 2021



#### 16.3 Test Arrangement

- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



- Note: 1. The EUT clearance from any metallic obstacles shall be at least 0,5 m.
  - 2. Interconnecting cables ( $\leq 1 \text{ m}$ ) belonging to the EUT shall remain on the insulating support.
  - 3. The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



# 16.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Bernie Lu	
Environmental conditions	23 °C, 62% RH	Test Date	2021/4/7	
Test mode	Mode 1			

Frequency (MHz)	Level (Vrms)	Tested Line	Injection Method	Return Path	Observation	Performance Criterion	Remark
0.15 – 10	3	AC Power	CDN-M3	CDN-M1	Note	А	
10 – 30	3 – 1	AC Power	CDN-M3	CDN-M1	Note	A	
30 - 80	1	AC Power	CDN-M3	CDN-M1	Note	A	
0.15 – 10	3	LAN 1	CDN-T8-10	CDN-M1	Note	A	-
10 – 30	3 – 1	LAN 1	CDN-T8-10	CDN-M1	Note	А	
30 - 80	1	LAN 1	CDN-T8-10	CDN-M1	Note	A	
0.15 – 10	3	AC Power	CDN-M3	CDN-M1	Note	А	
10 – 30	3 – 1	AC Power	CDN-M3	CDN-M1	Note	A	Audio
30 - 80	1	AC Power	CDN-M3	CDN-M1	Note	A	Audio
0.15 – 10	3	LAN 1	CDN-T8-10	CDN-M1	Note	A	output function
10 – 30	3 – 1	LAN 1	CDN-T8-10	CDN-M1	Note	А	TUTICUOT
30 - 80	1	LAN 1	CDN-T8-10	CDN-M1	Note	A	

Note: The EUT function was correct during the test.

Remark: Audio out function (Audio out) electrical reference level pass.

### 17 Power Frequency Magnetic Field Immunity Test

#### 17.1 Test Specification

Basic Standard:	EN/IEC 61000-4-8
Frequency Range:	50Hz
Field Strength:	1 A/m
Observation Time:	1 minute
Inductance Coil:	Rectangular type, 1 m x 1 m

#### 17.2 Test Instruments

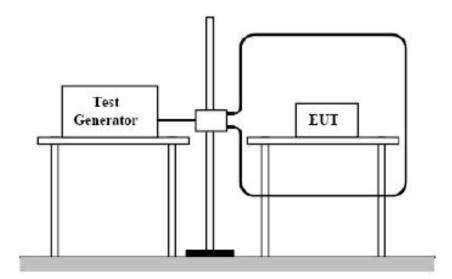
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
HAEFELY Magnetic Field Tester	MAG 100	083794-06	NA	NA
COMBINOVA Magnetic Field Meter	MFM10	224	May 7, 2020	May 6, 2021

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 1
- 3. Tested Date: Apr. 1, 2021

#### 17.3 Test Arrangement

- a. The equipment is configured and connected to satisfy its functional requirements.
- b. The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- c. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.



#### TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



# 17.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Thomas Cheng
Environmental conditions	22 °C, 69% RH	Test Date	2021/4/1
Test mode	Mode 1		

Application	Frequency (Hz)	Field Strength (A/m)	Observation	Performance Criterion
X - Axis	50	1	Note	A
Y - Axis	50	1	Note	A
Z - Axis	50	1	Note	A

Note: The EUT function was correct during the test.

## 18 Voltage Dips and Interruptions

### 18.1 Test Specification

Basic Standard:	EN/IEC 61000-4-11
Test levels:	Voltage Dips:
	<5% residual – 0.5 cycle,
	70% residual – 25 cycles
	Voltage Interruptions:
	<5% residual – 250 cycles
Interval between Event:	Minimum ten seconds
Sync Angle (degrees):	0° & 180°
Test Cycle:	3 times

#### 18.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Immunity Test System	Profline 2105	1632A00983 & 1639A01863	Jun. 9, 2020	Jun. 8, 2021
Software	WIN2120	NA	NA	NA

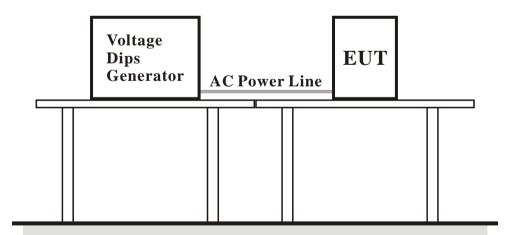
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in EMS Room No. 1.

3. Tested Date: Apr. 1, 2021

#### 18.3 Test Arrangement

The EUT shall be tested for each selected combination of test levels and duration with a sequence of 3 dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at 0 degree crossover point of the voltage waveform.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



#### 18.4 **Test Results**

Input Power	230 Vac, 50 Hz/ 240 Vac, 50 Hz/ 100 Vac, 50 Hz	Tested by	Thomas Cheng
Environmental conditions	22 °C, 69% RH	Test Date	2021/4/1
Test mode	Mode 1		

Input Power for testing: 230 Vac, 50 Hz (Nominal input Voltage)								
Voltage Residual (%)	Duration (cycle)	Interval (sec)	Times	Observation	Performance Criterion			
< 5	0.5	10	3	Note 1	A			
70	25	10	3	Note 1	A			
< 5	250	10	3	Note 2	С			

Input Power for testing: 240 Vac, 50 Hz (Maximum rated input voltage)								
Voltage Residual (%)	Duration (cycle)	Interval (sec)	Times	Observation	Performance Criterion			
< 5	0.5	10	3	Note 1	А			
70	25	10	3	Note 1	А			
< 5	250	10	3	Note 2	С			

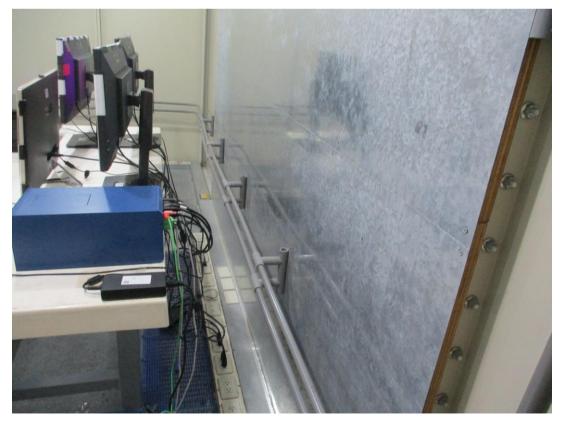
Input Power for testing: 100 Vac, 50 Hz (Minimum rated input voltage)							
Voltage Residual (%)	Duration (cycle)	Interval (sec)	Times	Observation	Performance Criterion		
< 5	0.5	10	3	Note 1	А		
70	25	10	3	Note 2	С		
< 5	250	10	3	Note 2	С		

Note:1. The EUT function was correct during the test.2. The EUT power off during the test, and must be recovered manually.

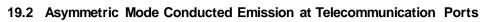


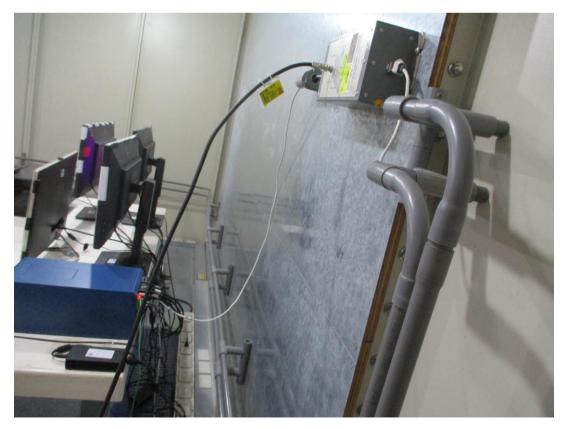
19.1 Conducted Emission from the AC Mains Power Port









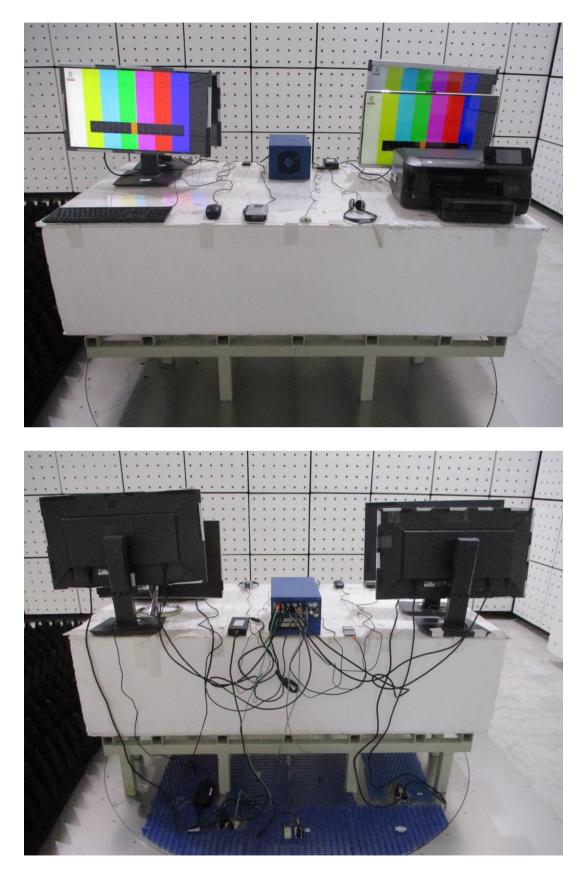






# 19.3 Radiated Emission at Frequencies up to 1GHz





# 19.4 Radiated Emission at Frequencies above 1GHz



# 19.5 Harmonics Current, Voltage Fluctuations and Flicker Measurement

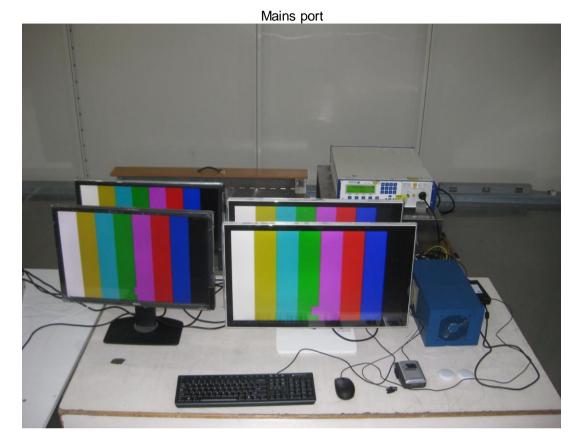
19.6 Electrostatic Discharge Immunity Test (ESD)



Report No.: CEBDBO-WTW-P21030872



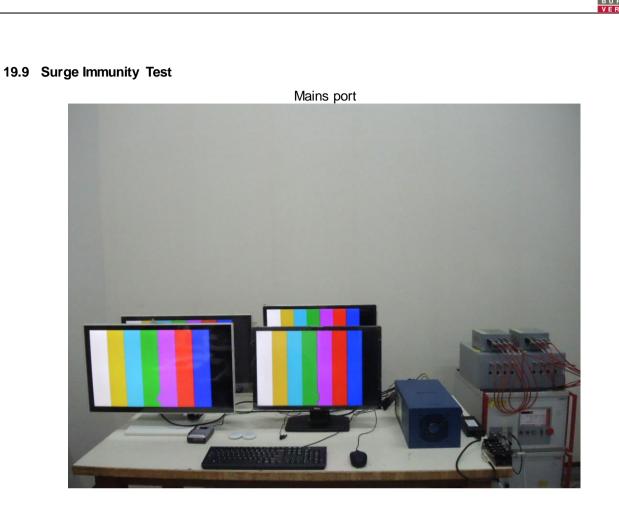
# 19.7 Radio-frequency, Electromagnetic Field Immunity Test (RS)

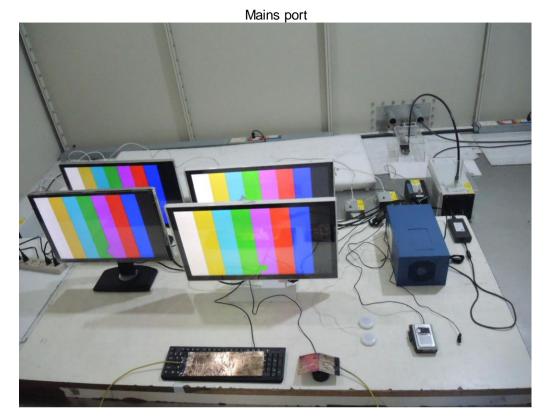


# 19.8 Electrical Fast Transient/Burst Immunity Test (EFT)

LAN port

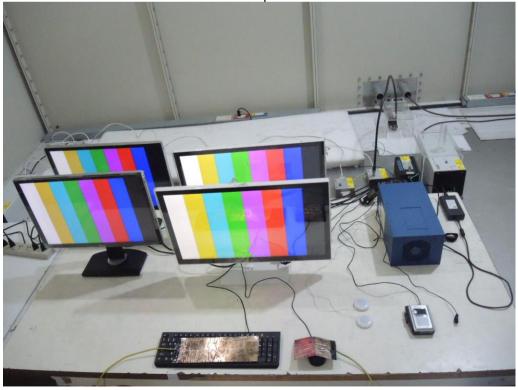






# 19.10 Conducted Disturbances Induced by RF Fields (CS)

LAN port





# 19.11 Power Frequency Magnetic Field Immunity Test (PFMF)

# 19.12 Voltage Dips and Interruptions





#### Appendix – Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

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Hwa Ya EMC/RF/Safety Lab Tel: 886-3-3183232 Fax: 886-3-3270892

Email: <u>service.adt@tw.bureauVeritas.com</u> Web Site: <u>www.bureauVeritas-adt.com</u>

The address and road map of all our labs can be found in our web site also.

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